11AA010/11LC010 11AA020/11LC020 11AA040/11LC040 11AA080/11LC080 11AA160/11LC160

1K-16K UNI/O® Serial EEPROM Family Data Sheet

Features:

- Single I/O, UNI/O® Serial Interface Bus
- Low-Power CMOS Technology
 - 1 mA active current, typical
 - 1 μA standby current (max.) (I-temp)
- 128 x 8 through 2,048 x 8 Bit Organizations
- Schmitt Trigger Inputs for Noise Suppression
- · Output Slope Control to Eliminate Ground Bounce
- 100 kbps Max. Bit Rate Equivalent to 100 kHz Clock Frequency
- Self-Timed Write Cycle (including Auto-Erase)
- · Page-Write Buffer for up to 16 Bytes
- STATUS Register for Added Control:
 - Write enable latch bit
 - Write-In-Progress bit
- Block Write Protection
 - Protect none, 1/4, 1/2 or all of array
- Built-in Write Protection
 - Power-on/off data protection circuitry
 - Write enable latch
- High Reliability
 - Endurance: 1,000,000 erase/write cycles
 - Data retention: > 200 years
 - ESD protection: > 4,000V
- 3-lead SOT-23 Package
- 8-lead PDIP, SOIC, MSOP, TDFN Packages
- · Pb-Free and RoHS Compliant
- Available Temperature Ranges:
 - Industrial (I): -40°C to +85°C
 Automotive (E): -40°C to +125°C

Pin Function Table

Name Function			
SCIO	Serial Clock, Data Input/Output		
Vss	Ground		
Vcc	Supply Voltage		

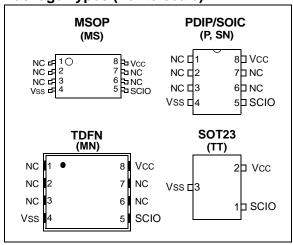
Description:

The Microchip Technology Inc. 11AAXXX/11LCXXX (11XX*) devices are a family of 1 Kbit through 16 Kbit Serial Electrically Erasable PROMs. The devices are organized in blocks of x8-bit memory and support the patented** single I/O UNI/O® serial bus. By using Manchester encoding techniques, the clock and data are combined into a single, serial bit stream (SCIO), where the clock signal is extracted by the receiver to correctly decode the timing and value of each bit.

Low-voltage design permits operation down to 1.8V (for 11AAXXX devices), with standby and active currents of only 1 uA and 1 mA, respectively.

The 11XX family is available in standard packages including 8-lead PDIP and SOIC, and advanced packaging including 3-lead SOT-23, 8-lead TDFN, and 8-lead MSOP.

Package Types (not to scale)



^{* 11}XX is used in this document as a generic part number for the 11 series devices.

^{**} Microchip's UNI/O® Bus products are covered by the following patent issued in the U.S.A.: 7,376,020.

11AAXXX/11LCXXX

DEVICE SELECTION TABLE

Part Number	Density (bits)	Organization	Vcc Range	Page Size (Bytes)	Temp. Ranges	Packages
11LC010	1K	128 x 8	2.5-5.5V	16	I,E	P, SN, MS, MN, TT
11AA010	1K	128 x 8	1.8-5.5V	16	I	P, SN, MS, MN, TT
11LC020	2K	256 x 8	2.5-5.5V	16	I,E	P, SN, MS, MN, TT
11AA020	2K	256 x 8	1.8-5.5V	16	I	P, SN, MS, MN, TT
11LC040	4K	512 x 8	2.5-5.5V	16	I,E	P, SN, MS, MN, TT
11AA040	4K	512 x 8	1.8-5.5V	16	I	P, SN, MS, MN, TT
11LC080	8K	1,024 x 8	2.5-5.5V	16	I,E	P, SN, MS, MN, TT
11AA080	8K	1,024 x 8	1.8-5.5V	16	I	P, SN, MS, MN, TT
11LC160	16K	2,048 x 8	2.5-5.5V	16	I,E	P, SN, MS, MN, TT
11AA160	16K	2,048 x 8	1.8-5.5V	16	I	P, SN, MS, MN, TT

1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (†)

Vcc	6.5V
SCIO w.r.t. Vss	0.6V to Vcc+1.0V
Storage temperature	65°C to 150°C
Ambient temperature under bias	40°C to 125°C
ESD protection on all pins	4 kV

† NOTICE: Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for an extended period of time may affect device reliability.

TABLE 1-1: DC CHARACTERISTICS

			Electrical C	haracteristi	cs:	
DC CHARACTERISTICS		Industrial (I): $VCC = 2.5V \text{ to } 5.5V$ $TA = -40^{\circ}C \text{ to } +85^{\circ}C$				
DC CHARACTERISTICS		Vcc = 1.8V to 2.				
			Automotive (E): $VCC = 2.5V \text{ to } 5.5$			0.5.5V TA = -40°C to +125°C
Param. No.	Sym.	Characteristic	Min.	Max.	Units	Test Conditions
D1	ViH	High-level input voltage	0.7*Vcc	Vcc+1	V	
D2	VIL	Low-level input voltage	-0.3 -0.3	0.3*Vcc 0.2*Vcc	V	Vcc ≥ 2.5V Vcc < 2.5V
D3	VHYS	Hysteresis of Schmitt Trigger inputs (SCIO)	0.05*Vcc	_	V	Vcc ≥ 2.5V (Note 1)
D4	Voн	High-level output voltage	Vcc -0.5 Vcc -0.5	_	V V	IOH = -300 μA, VCC = 5.5V IOH = -200 μA, VCC = 2.5V
D5	Vol	Low-level output voltage	_	0.4 0.4	V V	IOI = 300 μA, VCC = 5.5V IOI = 200 μA, VCC = 2.5V
D6	lo	Output current limit (Note 2)	_	±4 ±3	mA mA	Vcc = 5.5V (Note 1) Vcc = 2.5V (Note 1)
D7	lu	Input leakage current (SCIO)	_	±1	μΑ	VIN = VSS or VCC
D8	CINT	Internal Capacitance (all inputs and outputs)	_	7	pF	TA = 25°C, FCLK = 1 MHz, VCC = 5.0V (Note 1)
D9	Icc Read	Read Operating Current	_ _	3 1	mA mA	VCC=5.5V; FBUS=100 kHz, CB=100 pF VCC=2.5V; FBUS=100 kHz, CB=100 pF
D10	ICC Write	Write Operating Current	_	5 3	mA mA	Vcc = 5.5V Vcc = 2.5V
D11	Iccs	Standby Current	_	5	μΑ	VCC = 5.5V TA = 125°C
				1	μΑ	VCC = 5.5V TA = 85°C
D12	Icci	Idle Mode Current		50	μΑ	Vcc = 5.5V

Note 1: This parameter is periodically sampled and not 100% tested.

2: The SCIO output driver impedance will vary to ensure Io is not exceeded.

TABLE 1-2: AC CHARACTERISTICS

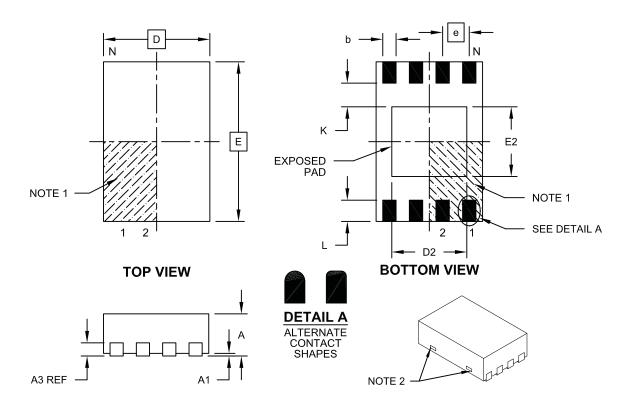
		Electrical Characteristics:					
AC CHARACTERISTICS		Industrial (I): $VCC = 2.5V \text{ to } 5.5V$ $TA = -40^{\circ}C \text{ to } +85^{\circ}C$					
			.5V TA = -20° C to $+85^{\circ}$ C				
		Automotive (E): $VCC = 2.5V$ to 5.			$TA = -40^{\circ}C \text{ to } +125^{\circ}C$		
Param. No.	Sym.	Characteristic	Min.	Max.	Units	Test Conditions	
1	FBUS	Serial bus frequency	10	100	kHz	_	
2	TE	Bit period	10	100	μs	_	
3	TIJIT	Input edge jitter tolerance		±0.08	UI	(Note 3)	
4	FDRIFT	Serial bus frequency drift rate tolerance		±0.75	% per byte	_	
5	FDEV	Serial bus frequency drift limit		±5	% per command	_	
6	TOJIT	Output edge jitter	_	±0.25	UI	(Note 3)	
7	TR	SCIO input rise time (Note 1)	_	100	ns	_	
8	TF	SCIO input fall time (Note 1)	_	100	ns	_	
9	Тѕтвү	Standby pulse time	600		μs	_	
10	Tss	Start header setup time	10		μs	_	
11	THDR	Start header low pulse time	5	_	μs	_	
12	TSP	Input filter spike suppression (SCIO)	_	50	ns	(Note 1)	
13	Twc	Write cycle time (byte or page)	_ _	5 10	ms ms	Write, WRSR commands ERAL, SETAL commands	
14	_	Endurance (per page)	1M	_	cycles	25°C, VCC = 5.5V (Note 2)	

- **Note 1:** This parameter is periodically sampled and not 100% tested.
 - 2: This parameter is not tested but ensured by characterization. For endurance estimates in a specific application, please consult the Total Endurance Model which can be obtained on Microchip's web site:
 - 3: A Unit Interval (UI) is equal to 1-bit period (TE) at the current bus frequency.

TABLE 1-3: AC TEST CONDITIONS

AC Waveform:					
VLO = 0.2V					
VHI = VCC - 0.2V					
CL = 100 pF					
Timing Measurement Reference Level					
Input	0.5 Vcc				
Output	0.5 Vcc				

8-Lead Plastic Dual Flat, No Lead Package (MN) – 2x3x0.75 mm Body [TDFN]



	MILLIMETERS					
Dimension Limits		MIN	NOM	MAX		
Number of Pins N			8			
Pitch	е		0.50 BSC			
Overall Height	Α	0.70	0.70 0.75 0.80			
Standoff	A1	0.00	0.02	0.05		
Contact Thickness	A3	0.20 REF				
Overall Length	D	2.00 BSC				
Overall Width	Е	3.00 BSC				
Exposed Pad Length	D2	1.20 - 1.60				
Exposed Pad Width	E2	1.20	-	1.60		
Contact Width	b	0.20	0.25	0.30		
Contact Length	L	0.25	0.30	0.45		
Contact-to-Exposed Pad	K	0.20	-	-		

Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Package may have one or more exposed tie bars at ends.
- 3. Package is saw singulated
- 4. Dimensioning and tolerancing per ASME Y14.5M $\,$

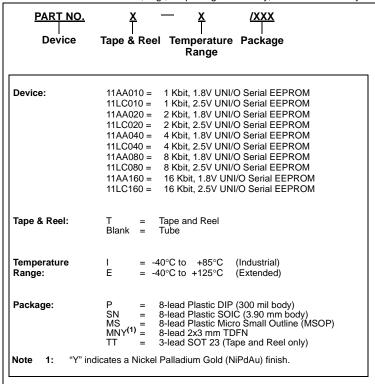
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-129B

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.



Examples:

- a) 11AA010-I/P = 1 Kbit, 1.8V Serial EEPROM, Industrial temp., PDIP package
- b) 11LC160T-E/TT = 16 Kbit, 2.5V Serial EEPROM, Extended temp., Tape & Reel, SOT-23 package
- c) 11AA080-I/MS = 8 Kbit, 1.8V Serial EEPROM, Industrial temp., MSOP package
- d) 11LC020T-I/SN = 2 Kbit, 2.5V Serial EEPROM, Industrial temp., Tape & Reel, SOIC package
- e) 11AA040T-I/MNY = 4 Kbit, 1.8V Serial EEPROM, Industrial temp., Tape and Reel, 2x3 mm TDFN package, Nickel Palladium Gold finish

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